

Notice of References Cited	Application/Control No. 10/599,192		Applicant(s)/Patent Under Reexamination HUITEMA ET AL.	
	Examiner CHRISTOPHER E. LEIBY		Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0156089	08-2003	Yamakawa et al.	345/96
*	B	US-2002/0067324	06-2002	Aoki, Toru	345/87
*	C	US-5,734,365	03-1998	Ohno et al.	345/97
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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